Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/628,748	CHEN ET AL.	
Examiner	Art Unit	
Steven H Rac	2814	

SEARCHED			
Class	Subclass	Date	Examiner
257	659	2/21/2006	SR
257	660	2/21/2006	SR
257	E23.114	2/21/2006	SR
438	18	2/21/2006	SR
174	34R	2/21/2006	SR
- 1			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
East/West	2/21/2006	SR
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